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A Rectangular Waveguide-to-Coplanar Waveguide Transition at D-band Using Wideband Patch Antenna

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Abstract—This paper presents the design of a transition at D-band (110–170 GHz) between rectangular waveguide and coplanar waveguide (CPW) using wideband patch antenna. With the rectangular ring structure, the proposed patch antenna is specialized for high gain and large bandwidth which can be used for wireless chip-to-chip communication or implemented as a rectangular waveguide-to-CPW transition. A simulated gain of 7.4 dBi with 36% bandwidth centered at 140 GHz is achieved. The fabricated rectangular waveguide-to-CPW transition in a back-to-back configuration exhibits a bandwidth of 42.2 GHz at D-band. From 118.8 GHz to 161 GHz, the return loss is better than 10 dB and each fabricated rectangular waveguide-to-CPW transition introduces less than 2 dB insertion loss.

Keywords—patch antennas, ultra wideband antennas, wireless communication, integrated circuit packaging.

I. INTRODUCTION

With the ever increasing demand worldwide for high-speed data transmission, wideband antennas have been widely used for wireless chip-to-chip communication as well as system integration and packaging at millimeter-wave and submillimeter-wave frequencies. However, not all types of antennas are suitable since the chips at such high frequencies mainly rely on planar structures due to their fabrication processes. The designs and implementations of wideband antennas are normally subjected to several concerns including the size, substrate, radiation characteristics, and operating bandwidth. The challenge is to achieve a high gain and at the same time a large bandwidth within a limited occupation area. Besides, the designed antenna should be compatible with the planar transmission lines used for the circuits, otherwise coplanar transitions might have to be added which introduce extra discontinuities and losses. As is reported in [1], a bandwidth of 29 GHz is achieved by the proposed Yagi antenna at W-band (75–110 GHz) which corresponds to 31.4% bandwidth while the gain is around 0.4 dBi at 94 GHz. In [2], by placing the stacked dielectric resonators on the top of the proposed meander slot antenna, a measured gain of 4.7 dBi is achieved at 130 GHz with 11% bandwidth. The directivity of the wideband antenna can be further increased by adding a hemisphere silicon lens on the top of the substrate or using an array with feeding networks while either extra chip-level assembly or large occupation area is required [3]–[5].

Fig. 1 shows the envisaged structure of the proposed wideband patch antenna when it is integrated on a chip. Conventional patch antenna has a certain dimension related to the operating frequency and simple planar structure which can be easily connected to different planar transmission lines. Being improved, the proposed patch antenna shown in Fig. 1 has a rectangular ring structure which increases the gain and enlarges the bandwidth without adding extra component. Besides, it is fed by CPW directly where the rectangular patch at the center is connected to the signal trace and the ground traces are designed as a part of the patch antenna. Apart from being used for wireless chip-to-chip communication, the proposed wideband patch antenna can also be implemented as a rectangular waveguide-to-CPW transition for system integration and packaging. The waveguide package not only provides isolation and protection to the chip but also serves as the standardized interface for connecting with other components and systems.

In this work, a wideband patch antenna for D-band applications is designed and analyzed by using High Frequency Structural Simulator (HFSS). In order to validate the concept, an antenna prototype based on quartz substrate is implemented which can be reconfigured for other substrates such as gallium arsenide (GaAs) or indium phosphide (InP). In Section II, the design of wideband patch antenna for wireless chip-to-chip communication is described. Besides, the simulated return loss and the far-field radiation characteristics are explained. In Section III, the optimization of the wideband patch antenna and the design of rectangular waveguide-to-CPW transition in a back-to-back configuration are demonstrated. In Section IV, the fabricated rectangular waveguide-to-CPW transition in a back-to-back configuration is shown and the measurement results are compared with the simulation results.

II. WIDEBAND PATCH ANTENNA FOR WIRELESS CHIP-TO-CHIP COMMUNICATION

The wideband patch antenna shown in Fig. 2 is designed for wireless chip-to-chip communication. In the communication link, the transceiver chips are aligned towards each other in the
direction of maximum radiation and the packaging structure can be avoided. The designed wideband patch antenna is patterned on a conductor layer which is located on the top of the quartz substrate. Besides, another conductor layer is added on the bottom which serves as a ground plane. The quartz substrate has a thickness of 150 µm and the material of the conductor layer is gold. Due to the skin effect, the thickness of the conductor layer should be more than the skin depth at the lower frequency limit of D-band. As a result, the conductor layer with a thickness of 400 nm is used for designing the wideband patch antenna.

As a part of the wideband patch antenna, a 50 Ω CPW feed with a length of 670 µm is included in the design which makes it possible for being integrated on-chip or connected with other circuits based on CPW. The width of the signal trace is 50 µm and the width of the ground traces is 100 µm with a gap width of 20 µm. The signal trace is connected to a patch which is cut into a rectangular ring connecting to a smaller rectangular patch at the center of the patch geometry. The ground traces are tapered out from 100 µm to 176 µm around the patch geometry forming another rectangular ring. The dimensions of the wideband patch antenna as well as the quartz substrate are summarized in Fig. 2. They are optimized for achieving the maximum bandwidth and gain at D-band. In order to simulate the far-field radiation characteristics, the coordinate system is assigned to the center of the patch geometry and an air box is added around the designed wideband patch antenna which is large enough reaching the antenna far-field region. Lumped port with vertical perfect electric conductor (PEC) bridge is used as the excitation scheme where the PEC bridge touches the ground traces and the port is assigned to a sheet between the signal trace and the PEC bridge. The parasitic inductance of the port is calibrated out from the simulation results.

The solid line in Fig. 3 shows the simulated return loss of the wideband patch antenna at D-band. With the rectangular ring structure, the wideband patch antenna achieves a bandwidth of 50.5 GHz ranging from 115.3 GHz to 165.6 GHz in which the simulated return loss remains better than 10 dB and it corresponds to 36% bandwidth centered at 140 GHz. The dashed lines in Fig. 3 show the simulated far-field radiation patterns of the wideband patch patch antenna at 140 GHz when φ equals 0° and 90°, respectively. A simulated antenna gain of 7.4 dBi is achieved in the direction perpendicular to the wideband patch antenna where θ equals 0° and 90°, respectively. Compared with the conventional patch antenna at D-band, larger bandwidth and higher gain can be provided by the proposed patch antenna while the occupation area is comparable.

III. WIDEBAND PATCH ANTENNA FOR RECTANGULAR WAVEGUIDE-TO-CPW TRANSITION

For system integration and packaging, the proposed wideband patch antenna can be implemented as a rectangular waveguide-to-CPW transition. Since rectangular waveguide serves as a standardized interface for connecting with other components and systems, the gain of the system can be further increased. As is reported in [7], the wireless chip-to-chip communication is realized by connecting a horn antenna to a rectangular waveguide-to-CPW transition which provides higher gain and larger bandwidth in comparison to the patch antenna itself. Fig. 4 shows the packaging structure of the proposed rectangular waveguide-to-CPW transition at D-band using wideband patch antenna.

The packaging structure shown in Fig. 4 is in a back-to-back configuration where WR-6.5 rectangular waveguides are used as the input and output guiding electromagnetic waves. At the beginning, the rectangular waveguide turns 90° towards the transition in the direction perpendicular to the wideband patch antenna. Besides, in order to guide electromagnetic waves smoothly and overcome the discontinuities, a tapered waveguide structure with a length of 1000 µm is introduced where the width is kept constant and the height is reduced from 825.5 µm to 680 µm. The wideband patch antenna is located at the end of the rectangular waveguide. The depth of the cavity is 150 µm which equals the thickness of the quartz substrate.
Due to the fabrication process, the cavity has rounded corners with a radius of 200 µm and they are included in the design for accuracy improvement. On the quartz substrate two transitions are connected by a CPW in the middle and the air cavity above the CPW has a height of 250 µm with the purpose of restricting parasitic modes.

When the proposed wideband patch antenna shown in Fig. 2 is implemented as a rectangular waveguide-to-CPW transition and aluminium is used for the packaging structure, the dimensions of the wideband patch antenna are optimized based on the new environment conditions. Fig. 5 shows the designed wideband patch antenna with optimized dimensions in a back-to-back configuration. The length and width of the quartz substrate are 2238 µm and 1050 µm, respectively. It is also the typical size of the transceiver chips at D-band. Besides, there is no gap between the quartz substrate and the walls of the cavity which helps to restrict parasitic modes and align the wideband patch antenna. The CPW in the middle of the quartz substrate has a length of 1200 µm which includes two antenna feeds and a connection. Unlike the wideband patch antenna designed for wireless communication which has a relatively large ground plane for radiation enhancement, the termination of the rectangular waveguide serves as the bottom ground plane for the optimized wideband patch antenna which results in a more compact design. The total length and width of the patch geometry are reduced to 628 µm and 1050 µm, respectively.

In order to simulate the proposed rectangular waveguide-to-CPW transition, wave ports are used as the excitation scheme and they are assigned to the input and output surfaces of the packaging structure. The magnitude of electric field distribution for the packaging structure at 140 GHz is shown in Fig. 6 in which the packaging structure is cut vertically in the middle along the long edge of the quartz substrate. At the beginning of the rectangular waveguide-to-CPW transition, the electric fields going through the tapered waveguide structure are compressed and coupled into the wideband patch antenna. Due to the rectangular ring structure on the patch geometry, the electric fields are concentrated in the slots. Since the wideband patch antennas on the quartz substrate are fed by a CPW, the electric fields mainly exist in the two gaps between the signal and ground traces. With the carefully designed wideband patch antenna as well as the tapered waveguide structure, the proposed rectangular waveguide-to-CPW transition can provide a large bandwidth at D-band which does not introduce high transmission loss or strong reflection and the propagation mode is converted smoothly.

**IV. FABRICATION AND EXPERIMENTAL RESULTS**

In order to prove the concept, the rectangular waveguide-to-CPW transition using wideband patch antenna shown in Fig. 4 was fabricated in a back-to-back configuration. For easier fabrication and substrate alignment, the aluminium packaging structure was divided into three parts and each part was fabricated from an aluminium block by a milling process which uses a spinner with a radius of 200 µm. Fig. 7 shows the fabricated packaging structure and the quartz substrate in a back-to-back configuration. For assembly, two parts on the top contain the input and output WR-6.5 rectangular waveguides which are connected by using two guide pins and two screws. The cavity for the quartz substrate was milled on the bottom part where four guide pins and four screws are used for combining it with other two parts.
The proposed transition in a back-to-back configuration was fabricated at Danchip (National Center for Microand Nanofabrication in Denmark). The quartz substrate was cleaned by sputtering at the beginning. After that a titanium layer with a thickness of 30 nm and a gold layer with a thickness of 400 nm were deposited on the top where the titanium layer was used to improve the adhesion of the gold layer. The wideband patch antennas and the CPW were patterned on the quartz substrate by laser ablation which uses a picosecond laser with a wavelength of 355 nm focused down to a spot size of approximate 10 µm. For dicing process, the patterned quartz substrate was stuck on a silicon wafer in order to overcome the stress. Besides, silver conductive glue was used to fill the gaps between the quartz substrate and the walls of the cavity.

The measurement system consists of an Anritsu ME7808B vector network analyzer (VNA) and two VDI WR-6.5 waveguide extenders which can measure scattering parameters from 110 GHz to 170 GHz. For accuracy improvement, through-reflect-line (TRL) calibration was applied by using a waveguide calibration kit. The scattering parameters were calibrated to the input and output of the fabricated packaging structure. The measurement results of the proposed rectangular waveguide-to-CPW transition in a back-to-back configuration are shown in Fig. 8 in comparison with the simulation results. The measured return loss is better than 10 dB from 118.8 GHz to 161 GHz which corresponds to a bandwidth of 42.2 GHz at D-band. Each fabricated rectangular waveguide-to-CPW transition introduces less than 2 dB insertion loss.

![Fig. 8. Simulation and measurement results of the proposed rectangular waveguide-to-CPW transition in a back-to-back configuration.](image)

V. CONCLUSION

The designs of wideband patch antennas at D-band used for wireless chip-to-chip communication and rectangular waveguide-to-CPW transition have been presented. For wireless chip-to-chip communication, the proposed wideband patch antenna shows a simulated gain of 7.4 dBi with 36% bandwidth centered at 140 GHz which corresponds to a bandwidth of 50.3 GHz ranging from 115.3 GHz to 165.6 GHz. For system integration and packaging, a rectangular waveguide-to-CPW transition in a back-to-back configuration has been designed, fabricated, and measured. The assembly structure has been illustrated in which the aluminium package was divided into three parts. Besides, for accuracy improvement, TRL calibration has been applied to the measurement by using a waveguide calibration kit. The measured return loss is better than 10 dB from 118.8 GHz to 161 GHz which corresponds to a bandwidth of 42.2 GHz at D-band. Each fabricated rectangular waveguide-to-CPW transition introduces less than 2 dB insertion loss.

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